


<b>Search Notes</b>  	<b>Application/Control No.</b>  10582168	<b>Applicant(s)/Patent Under Reexamination</b>  CHEN ET AL.
	<b>Examiner</b>  William C Doerrler	<b>Art Unit</b>  3744

SEARCHED			
Class	Subclass	Date	Examiner
62	6, 277	12-3-2008	WCD
165	104.21	12-5-2008	WCD

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Search - see report	12-5-2008	WCD

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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